## **FEATURES**

- Access time :55ns
- Low power consumption:

Operation current:

15mA (TYP.), Vcc = 3.0V

Standby current:

 $1\mu A$  (TYP.),  $V_{CC} = 3.0V$ 

- Wide range power supply : 2.7 ~ 5.5V
- Fully Compatible with all Competitors 5V product
- Fully Compatible with all Competitors 3.3V product
- Fully static operation
- Tri-state output
- Data retention voltage : 2.0V (MIN.)
- All products ROHS Compliant
- Package : 28-pin 600 mil PDIP

28-pin 330 mil SOP

28-pin 8mm x 13.4mm sTSOP

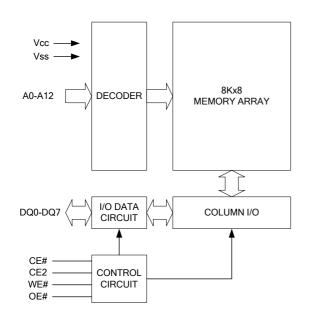
## **GENERAL DESCRIPTION**

The AS6C6264 is a 65,536-bit low power CMOS static random access memory organized as 8,192 words by 8 bits. It is fabricated using very high performance, high reliability CMOS technology. Its standby current is stable within the range of operating temperature.

The AS6C6264 is well designed for low power application, and particularly well suited for battery back-up nonvolatile memory application.

The AS6C6264 operates with wide range power supply.

#### **FUNCTIONAL BLOCK DIAGRAM**

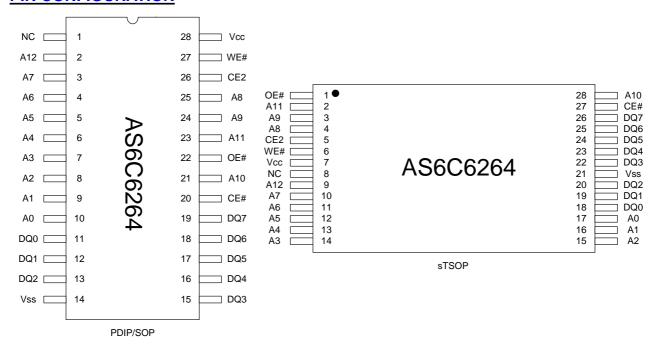


#### **PIN DESCRIPTION**

SYMBOL	DESCRIPTION
A0 - A12	Address Inputs
DQ0 – DQ7	Data Inputs/Outputs
CE#, CE2	Chip Enable Inputs
WE#	Write Enable Input
OE#	Output Enable Input
Vcc	Power Supply
Vss	Ground
NC	No Connection



## **PIN CONFIGURATION**



## **ABSOLUTE MAXIMUM RATINGS\***

PARAMETER	SYMBOL	RATING	UNIT
Terminal Voltage with Respect to Vss	VTERM	-0.5 to 7.0	V
		0 to 70(C grade)	
Operating Temperature	TA		°C
		-40 to 85(I grade)	
Storage Temperature	Тѕтс	-65 to 150	°C
Power Dissipation	PD	1	W
DC Output Current	Іоит	50	mA
Soldering Temperature (under 10 sec)	Tsolder	260	°C

<sup>\*</sup>Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to the absolute maximum rating conditions for extended period may affect device reliability.

#### TRUTH TABLE

MODE	CE#	CE2	OE#	WE#	I/O OPERATION	SUPPLY CURRENT
Standby	Н	Х	Х	Х	High-Z	Isb,Isb1
Staridby	Х	L	Х	Х	High-Z	Isb,Isb1
Output Disable	L	Н	Н	Н	High-Z	Icc,Icc1
Read	L	Н	L	Н	Dout	lcc,lcc1
Write	L	Н	Х	L	Din	lcc,lcc1

Note: H = V<sub>IH</sub>, L = V<sub>IL</sub>, X = Don't care.



# **DC ELECTRICAL CHARACTERISTICS**

PARAMETER	SYMBOL	TEST CONDIT	ION	MIN.	TYP. *5	MAX.	UNIT
Supply Voltage	Vcc			2.7	3.0	5.5	V
Input High Voltage	V <sub>IH</sub> <sup>*1</sup>		·	0.7*Vcc	•	Vcc+0.3	V
Input Low Voltage	V <sub>IL</sub> *2			- 0.5	ı	0.6	V
Input Leakage Current	ILI	$V_{CC} \ge V_{IN} \ge V_{SS}$		- 1	-	1	μA
Output Leakage Current	ILO	$V_{CC} \ge V_{OUT} \ge V_{SS}$ , Output Disabled		- 1	-	1	μΑ
Output High Voltage	Vон	Iон = -1mA		2.4	3.0	-	V
Output Low Voltage	Vol	I <sub>OL</sub> = 2mA		-	-	0.4	V
Average Operating	lcc	Cycle time = Min. $CE\# = V_{IL}$ and $CE2 = I_{I/O} = 0mA$	V <sub>IH</sub> , - 55	-	15	45	mA
Power supply Current	Icc1	Cycle time = $1\mu$ s CE# $\leq$ 0.2V and CE2 $\geq$ $I_{VO}$ = 0mA other pins at 0.2V or \	•	-	3	10	mA
Standby Power	ISB1	_	-C		1	50 <sup>⁴</sup>	μA
Supply Current	1361	or CE2≦0.2V	-l	-	1	80 <sup>4</sup>	μΑ

Notes: C = Commercial Temperature I = Industrial temperature

- 1. V<sub>H</sub>(max) = V<sub>C</sub> + 30V for pulse width less than 10ns 2. V<sub>L</sub>(min) = V<sub>S</sub> 3.0V for pulse width less than 10ns.
- 3. OverUndershoot specifications are characterized, not 10% tested.
- 4. 10µA for special request
- 5. Typical valuesare included foreference only and are nonguaranteed or tested. Typical valued are measuredt alcc = Vcc(TYP.) and TA = 25°C

## CAPACITANCE (TA = $25^{\circ}$ , f = 1.0MHz)

PARAMETER	SYMBOL	MIN.	MAX	UNIT
Input Capacitance	Cin	-	6	pF
Input/Output Capacitance	Cı/o	-	8	pF

Note: These parameters are guaranteed by device characterization, but not ropduction tested.

## **AC TEST CONDITIONS**

Input Pulse Levels	0.2V to Vcc - 0.2V
Input Rise and Fall Times	3ns
Input and Output Timing Reference Levels	1.5V
Output Load	$C_L = 50pF + 1TTL$ , $I_{OH}/I_{OL} = -1mA/2mA$

# **AC ELECTRICAL CHARACTERISTICS**

# (1) READ CYCLE

PARAMETER	SYM.	SYM. AS6C6264-55			UNIT		
				MIN.	MAX.		
Read Cycle Time	trc			55	-		ns
Address Access Time	taa			-	55		ns
Chip Enable Access Time	<b>t</b> ACE			-	55		ns
Output Enable Access Time	toe				30		ns
Chip Enable to Output in Low-Z	tcLz*			10	-		ns
Output Enable to Output in Low-Z	tolz*			5	-		ns
Chip Disable to Output in High-Z	tcHz*			-	20		ns
Output Disable to Output in High-Z	tonz*				20		ns
Output Hold from Address Change	tон			10	-		ns

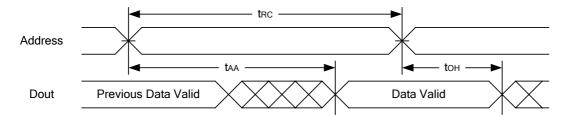
## (2) WRITE CYCLE

PARAMETER	SYM.	SYM. AS6C6		6264-55		UNIT	
				MIN.	MAX.		
Write Cycle Time	twc			55	-		ns
Address Valid to End of Write	taw			50	-		ns
Chip Enable to End of Write	tcw			50	-		ns
Address Set-up Time	tas			0	-		ns
Write Pulse Width	twp			45	-		ns
Write Recovery Time	twr			0	-		ns
Data to Write Time Overlap	tow			25	-		ns
Data Hold from End of Write Time	tон			0	-		ns
Output Active from End of Write	tow*			5	-		ns
Write to Output in High-Z	twnz*			-	20		ns

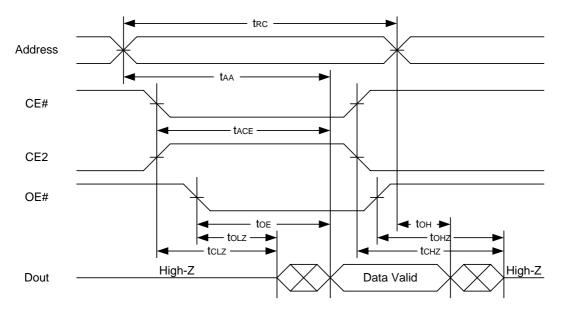
<sup>\*</sup>These parameters are guaranteed by device characterization, but not production tested.

## **TIMING WAVEFORMS**

#### **READ CYCLE 1** (Address Controlled) (1,2)



## READ CYCLE 2 (CE# and CE2 and OE# Controlled) (1,3,4,5)

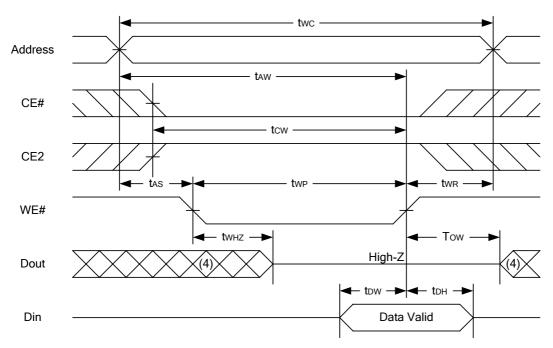


#### Notes:

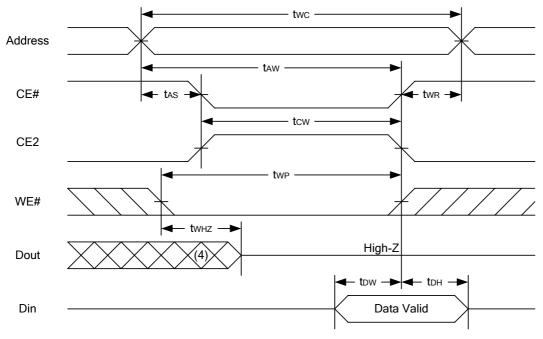
- 1.WE# is high for read cycle.
- 2.Device is continuously selected OE# = low, CE# = low., CE2 = high.
- 3.Address must be valid prior to or coincident with CE# = low, CE2 = high; otherwise tAA is the limiting parameter.
- 4.tclz, tolz, tchz and tohz are specified with  $C_L = 5pF$ . Transition is measured  $\pm 500 \text{mV}$  from steady state.
- 5.At any given temperature and voltage condition,  $t_{CHZ}$  is less than  $t_{CLZ}$ ,  $t_{OHZ}$  is less than  $t_{OLZ}$ .



#### WRITE CYCLE 1 (WE# Controlled) (1,2,3,5,6)



#### WRITE CYCLE 2 (CE# and CE2 Controlled) (1,2,5,6)



#### Notes:

- 1.WE#, CE# must be high or CE2 must be low during all address transitions.
- 2.A write occurs during the overlap of a low CE#, high CE2, low WE#.
- 3.During a WE#controlled write cycle with OE# low, twp must be greater than twHz + tow to allow the drivers to turn off and data to be placed on the bus.
- 4. During this period, I/O pins are in the output state, and input signals must not be applied.
- 5.If the CE#low transition and CE2 high transition occurs simultaneously with or after WE# low transition, the outputs remain in a high impedance state.
- 6.tow and twHz are specified with  $C_L = 5pF$ . Transition is measured  $\pm 500mV$  from steady state.



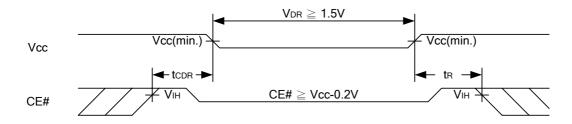
# **DATA RETENTION CHARACTERISTICS**

PARAMETER	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Vcc for Data Retention	1 1/00		1.5	-	5.5	V
Data Retention Current	I <sub>DR</sub>	Vcc = 1.5 $VCE\# \ge Vcc - 0.2Vor CE2 \le 0.2V$	-	0.5	10	μA
Chip Disable to Data Retention Time	tcdr	See Data Retention Waveforms (below)	0	-	-	ns
Recovery Time	<b>t</b> R		<b>t</b> RC∗	-	-	ns

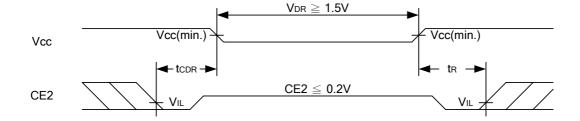
tRC∗ = Read Cycle Time

## **DATA RETENTION WAVEFORM**

Low Vcc Data Retention Waveform (1) (CE# controlled)



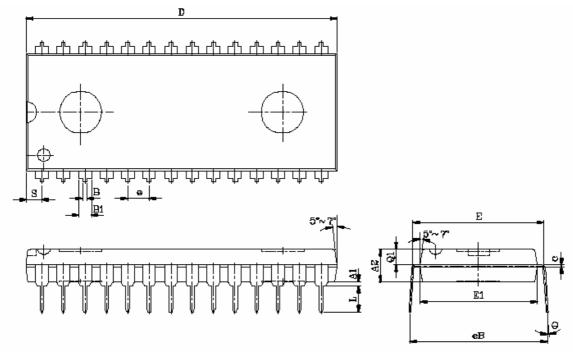
Low Vcc Data Retention Waveform (2) (CE2 controlled)





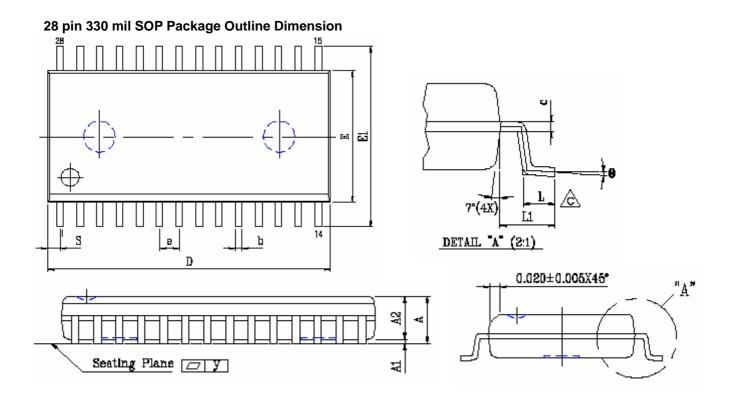


# 28 pin 600 mil PDIP Package Outline Dimension



SYM. UNIT	INCH.(BASE)	MM(REF)
A1	0.010 (MIN)	0.254 (MIN)
A2	0.150±0.005	3.810±0.127
В	0.020 (MAX)	0.508(MAX)
B1	0.055 (MAX)	1.397(MAX)
С	0.012 (MAX)	0.304 (MAX)
D	1.430 (MAX)	36.322 (MAX)
E	0.6 (TYP)	15.24 (TYP)
E1	0.52 (MAX)	13.208 (MAX)
е	0.100 (TYP)	2.540(TYP)
eB	0.625 (MAX)	15.87 (MAX)
L	0.180(MAX)	4.572(MAX)
S	0.06 (MAX)	1.524 (MAX)
Q1	0.08(MAX)	2.032(MAX)
Θ	15°(MAX)	15°(MAX)

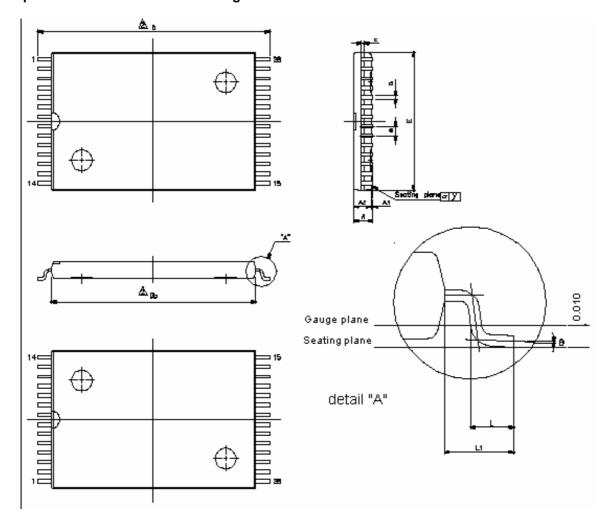




SYM. UNIT	INCH(BASE)	MM(REF)
Α	0.120 (MAX)	3.048 (MAX)
A1	0.002(MIN)	0.05(MIN)
A2	0.098±0.005	2.489±0.127
b	0.016 (TYP)	0.406(TYP)
С	0.010 (TYP)	0.254(TYP)
D	0.728 (MAX)	18.491 (MAX)
Е	0.340 (MAX)	8.636 (MAX)
E1	0.465±0.012	11.811±0.305
е	0.050 (TYP)	1.270(TYP)
L	0.05 (MAX)	1.270 (MAX)
L1	0.067±0.008	1.702 ±0.203
S	0.047 (MAX)	1.194 (MAX)
у	0.003(MAX)	0.076(MAX)
Θ	0°~10°	0°~10°



## 28 pin 8mm x 13.4mm sTSOP Package Outline Dimension



SYM. UNIT	INCH(BASE)	MM(REF)
Α	0.047 (MAX)	1.20 (MAX)
A1	0.004±0.002	0.10±0.05
A2	0.039±0.002	1.00±0.05
b	0.006 (TYP)	0.15(TYP)
С	0.010 (TYP)	0.254(TYP)
Db	0.465±0.004	11.80±0.10
Е	0.315±0.004	8.00±0.10
е	0.022 (TYP)	0.55(TYP)
D	0.528±0.008	13.40±0.20
L	0.020±0.004	0.50±0.10
L1	0.0315±0.004	0.80±0.10
у	0.08(MAX)	0.003(MAX)
Θ	0°~5°	0°∼5°

Note: E dimension is not including end flash. The total of both sides' end flash is not above 0.3mm.



AS6C6264

# **ORDERING INFORMATION**

# **Ordering Codes**

				Operating	Speed
Alliance	Organization	<b>VCC</b> range	Package	Temp	ns
				Commercial ~	
AS6C6264-55PCN	8k x 8	2.7-5.5V	28pin 600mil PDIP	0° C to 70° C	55
				Commercial ~	
AS6C6264-55SCN	8k x 8	2.7-5.5V	28pin 330mil SOP	0° C to 70° C	55
				Industrial ~	
AS6C6264-55SIN	8k x 8	2.7-5.5V	28pin 330mil SOP	-40°C to 85° C	55
				Commercial ~	
AS6C6264-55STCN	8k x 8	2.7-5.5V	28pin sTSOP (8 x 13.4 mm)	0° C to 70° C	55
				Industrial ~	
AS6C6264-55STIN	8k x 8	2.7-5.5V	28pin sTSOP (8 x 13.4 mm)	-40°C to 85° C	55

# Part numbering system

AS6C	6264	- 55	X	X	N
				Temperature Range:	
low			Package Options:	C = Commercial	N = Lead
power	Device		P = 28 pin 600 mil P-DIP	(0°C to +70° C)	Free ROHS
SRAM	Number	Access	S = 28 pin 330 mil SOP	I = Industrial	Compliant
prefix	6264	Time	ST = 28 pin sTSOP (8mm x 13.4 mm)	(-40° to +85° C)	Part

February 2007 AS6C6264





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Part Number: AS6C6264 Document Version: v. 1.0

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